

MOSFET

OptiMOS[™] 3 Power-Transistor, 200 V

Features

- Ideal for high frequency switching and sync. rec.
 Excellent gate charge x R_{DS(on)} product (FOM)
 Very low on-resistance R_{DS(on)}
 N-channel, normal level

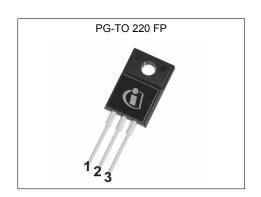
- 100% avalanche tested
- Pb-free plating; RoHS compliant
 Halogen-free according to IEC61249-2-21

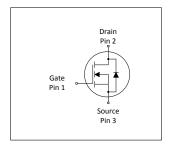
Product validation

Qualified according to JEDEC Standard

Kev Performance Parameters Table 1

Take 1 Troj i eliterinanio i antanio tere							
Parameter	Value	Unit					
V _{DS}	200	V					
R _{DS(on),max}	32	mΩ					
I_{D}	26	A					
Qoss	54	nC					
Q _G (0V10V)	22	nC					











Type / Ordering Code	Package	Marking	Related Links
IPA320N20NM3S	PG-TO 220 FullPAK	320N203S	-

OptiMOSTM 3 Power-Transistor, 200 V IPA320N20NM3S



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OptiMOS[™] 3 Power-Transistor, 200 V **IPA320N20NM3S**



1 Maximum ratings at T_A =25 °C, unless otherwise specified

Maximum ratings Table 2

Davamatas	Symbol	Values			1114	
Parameter		Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current	ID	-	-	26 19	А	V _{GS} =10 V, T _C =25 °C V _{GS} =10 V, T _C =100 °C
Pulsed drain current ¹⁾	I _{D,pulse}	-	-	104	Α	<i>T</i> _C =25 °C
Avalanche energy, single pulse ²⁾	E _{AS}	-	-	190	mJ	I_D =26 A, R_{GS} =25 Ω
Gate source voltage	V _{GS}	-20	-	20	V	-
Power dissipation	P _{tot}	-	-	38	W	<i>T</i> _C =25 °C
Operating and storage temperature	T _j , T _{stg}	-55	-	175	°C	IEC climatic category; DIN IEC 68-1: 55/175/56

2 Thermal characteristics

Table 3 Thermal characteristics

Doromotor	Values			11:4		Note / Tost Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Thermal resistance, junction - case	R _{thJC}	-	-	3.9	°C/W	-	

3 Electrical characteristics at T_j =25 °C, unless otherwise specified

Table 4 **Static characteristics**

Damawa atau	Ob. a.l.		Values			Note / Took Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	200	-	-	V	V _{GS} =0 V, I _D =1 mA
Gate threshold voltage	$V_{\rm GS(th)}$	2	3	4	V	$V_{\rm DS}$ = $V_{\rm GS}$, $I_{\rm D}$ =89 $\mu {\rm A}$
Zero gate voltage drain current	I _{DSS}	-	0.1 10	1 100	μA	V _{DS} =160 V, V _{GS} =0 V, T _j =25 °C V _{DS} =160 V, V _{GS} =0 V, T _j =125 °C
Gate-source leakage current	I _{GSS}	-	1	100	nA	V _{GS} =20 V, V _{DS} =0 V
Drain-source on-state resistance	R _{DS(on)}	-	27.2	32.0	mΩ	V _{GS} =10 V, I _D =26 A
Gate resistance ³⁾	R _G	-	2.5	-	Ω	-
Transconductance	g fs	-	48	-	S	$ V_{DS} \ge 2 I_D R_{DS(on)max}, I_D = 26 A$

See Diagram 3 for more detailed information
 See Diagram 13 for more detailed information
 Defined by design. Not subject to production test.

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Table 5 Dynamic characteristics

Downwater.	Symbol	Values			I I m i 4	Nata / Taat Canditian
Parameter		Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance ¹⁾	Ciss	-	1800	2300	pF	V _{GS} =0 V, V _{DS} =100 V, f=1 MHz
Output capacitance	Coss	-	140	-	pF	V _{GS} =0 V, V _{DS} =100 V, f=1 MHz
Reverse transfer capacitance	C _{rss}	-	5	-	pF	V _{GS} =0 V, V _{DS} =100 V, f=1 MHz
Turn-on delay time	$t_{ m d(on)}$	-	11	-	ns	$V_{\rm DD}$ =100 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =13 A, $R_{\rm G,ext}$ =1.6 Ω
Rise time	t _r	-	9	-	ns	$V_{\rm DD}$ =100 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =13 A, $R_{\rm G,ext}$ =1.6 Ω
Turn-off delay time	$t_{ m d(off)}$	-	21	-	ns	$V_{\rm DD}$ =100 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =13 A, $R_{\rm G,ext}$ =1.6 Ω
Fall time	t _f	-	4	-	ns	$V_{\rm DD}$ =100 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =13 A, $R_{\rm G,ext}$ =1.6 Ω

Table 6 Gate charge characteristics²⁾

Danamatan	Symbol	Values				
Parameter		Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	8	-	nC	$V_{\rm DD}$ =100 V, $I_{\rm D}$ =13 A, $V_{\rm GS}$ =0 to 10 V
Gate charge at threshold	$Q_{g(th)}$	-	5	-	nC	$V_{\rm DD}$ =100 V, $I_{\rm D}$ =13 A, $V_{\rm GS}$ =0 to 10 V
Gate to drain charge	Q _{gd}	-	3	-	nC	$V_{\rm DD}$ =100 V, $I_{\rm D}$ =13 A, $V_{\rm GS}$ =0 to 10 V
Switching charge	Q _{sw}	-	5	-	nC	$V_{\rm DD}$ =100 V, $I_{\rm D}$ =13 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total ¹⁾	Qg	-	22	30	nC	$V_{\rm DD}$ =100 V, $I_{\rm D}$ =13 A, $V_{\rm GS}$ =0 to 10 V
Gate plateau voltage	V _{plateau}	-	4.3	-	V	$V_{\rm DD}$ =100 V, $I_{\rm D}$ =13 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total, sync. FET	Q _{g(sync)}	-	20	-	nC	V _{DS} =0.1 V, V _{GS} =0 to 10 V
Output charge	Q _{oss}	-	54	-	nC	V _{DD} =100 V, V _{GS} =0 V

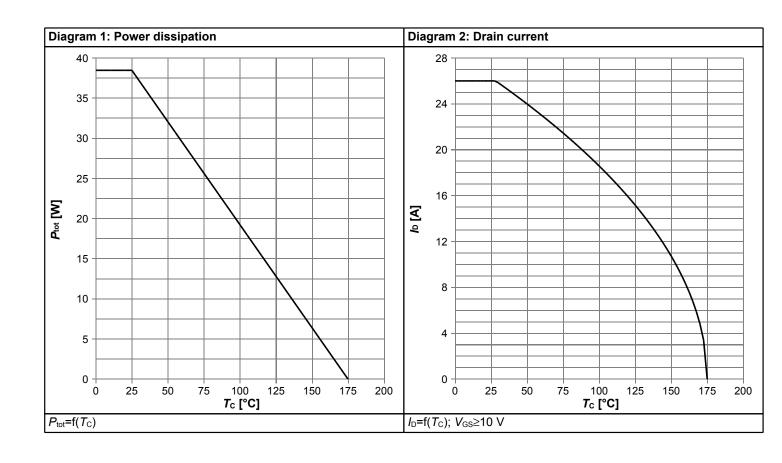
Table 7 Reverse diode

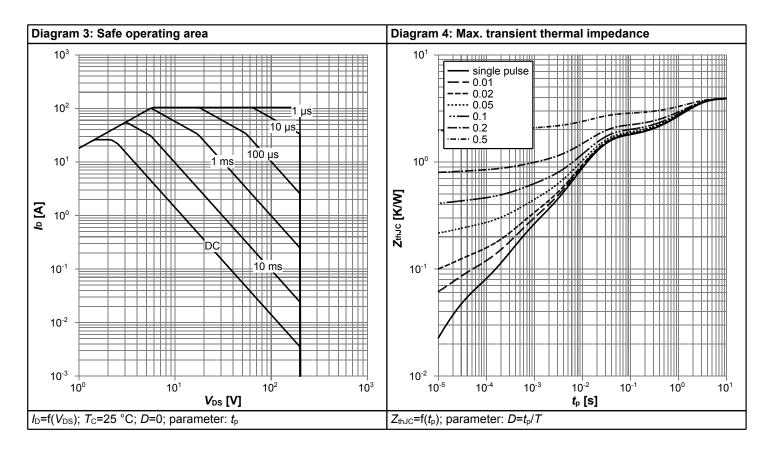
Parameter	Symbol	Values			Unit	Note / Test Condition
raiailletei	Symbol	Min.	Тур.	Max.	Offic	Note / Test Condition
Diode continuous forward current	Is	-	-	26	Α	<i>T</i> _C =25 °C
Diode pulse current	I _{S,pulse}	-	-	104	Α	T _C =25 °C
Diode forward voltage	V _{SD}	-	0.94	1.2	V	V _{GS} =0 V, I _F =26 A, T _j =25 °C
Reverse recovery charge ¹⁾	Q _{rr}	-	500	-	nC	V_R =100 V, I_F =13 A, di_F/dt =100 A/ μ s

 $^{^{1)}}$ Defined by design. Not subject to production test. $^{2)}$ See "Gate charge waveforms" for parameter definition

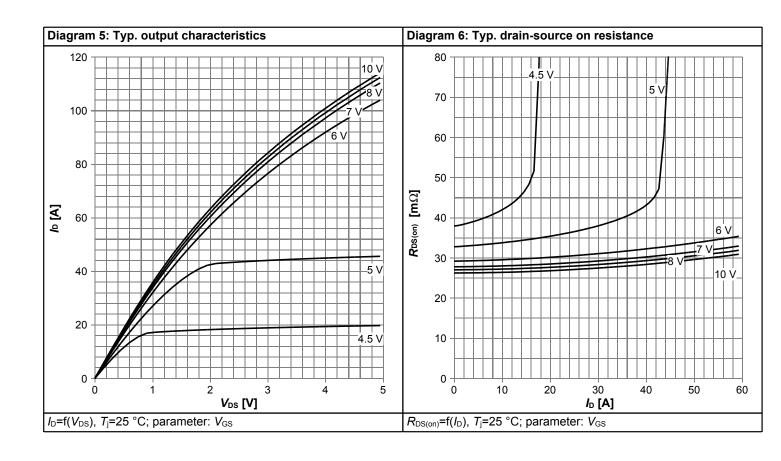


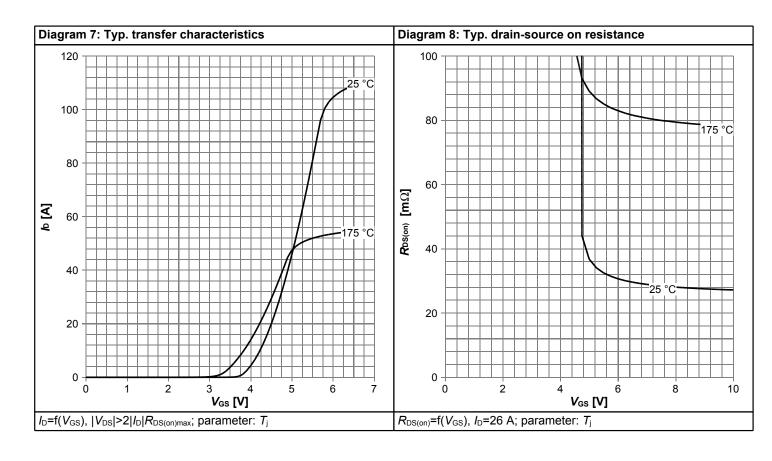
4 Electrical characteristics diagrams



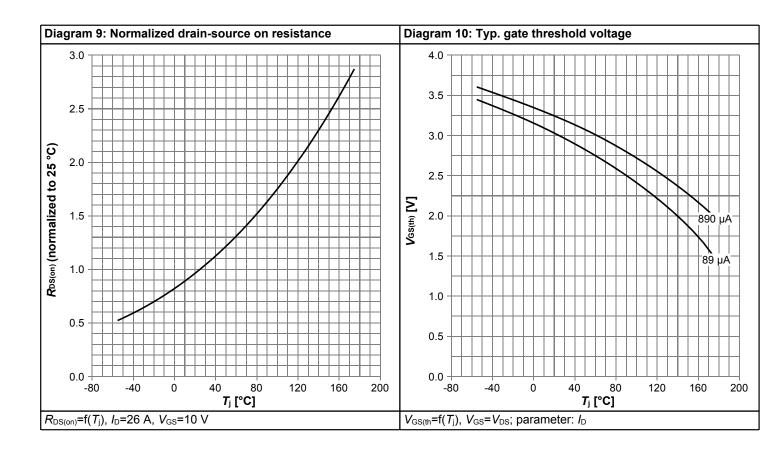


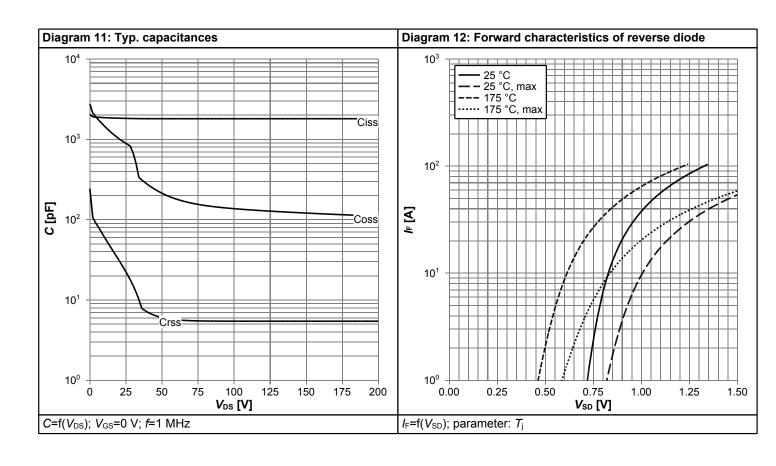




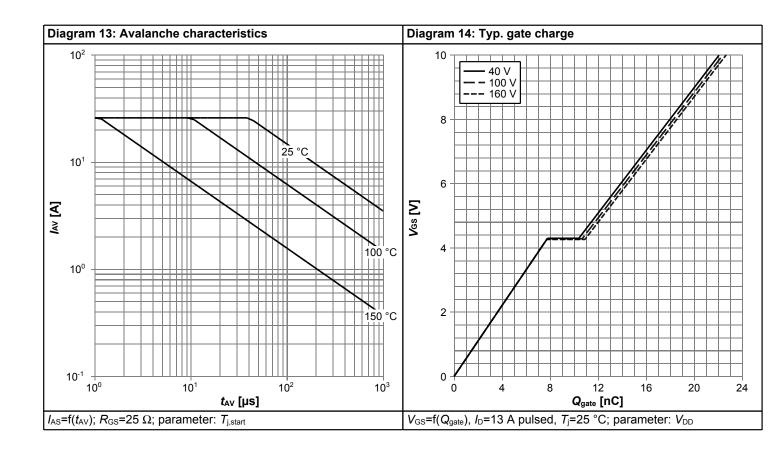


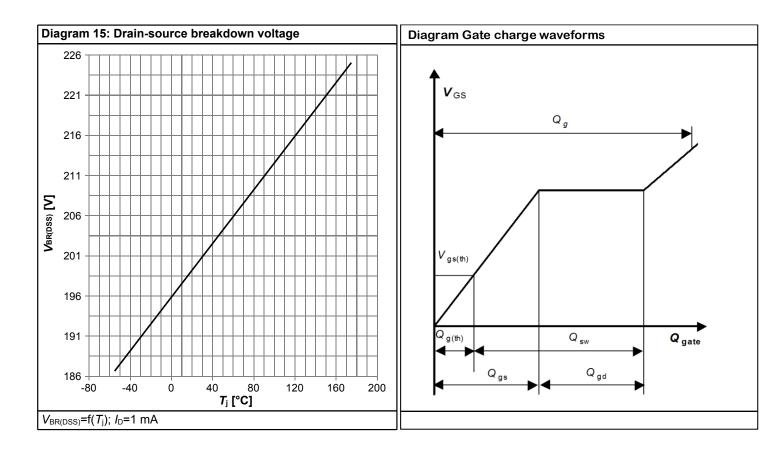














5 Package Outlines

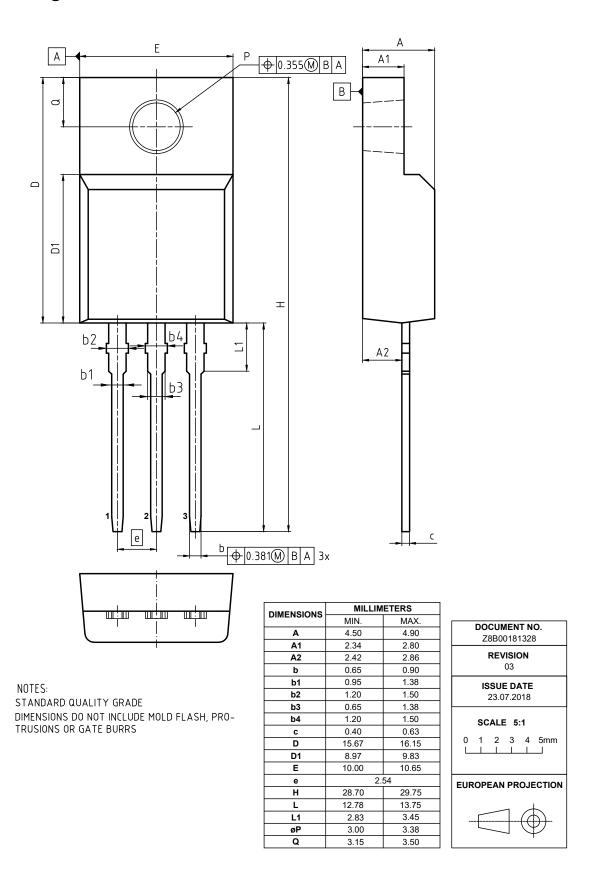


Figure 1 Outline PG-TO 220 FullPAK, dimensions in mm/inches

OptiMOS[™] 3 Power-Transistor, 200 V IPA320N20NM3S



Revision History

IPA320N20NM3S

Revision: 2019-09-02, Rev. 2.1

Previous Revision

Trevious Revision						
Revision	ision Date Subjects (major changes since last revision)					
2.0	2019-07-18	Release of final version				
2.1	2019-09-02	Update package outline				

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